



TEST REPORT



Report No. : KES-EM252060

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KES Co., Ltd.

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1. Client

Applicant : Hanwha Vision Co., Ltd.

Applicant Address : 6, Pangyo-ro 319Beon-gil, Bundang-gu, Seongnam-si, Gyeonggi-do, Republic of Korea

2. Sample Description

Product name : LENS MODULE

Model/Type No. : SLA-F4780A

Variant Model : -

Manufacturer : 1. HANWHA VISION VIETNAM COMPANY LIMITED
2. D-TECH CO.,LTD.

Manufacturer Address : 1. Lot O-2, Que Vo Industrial Zone extended Area, Nam Son Ward, Bac Ninh City, Bac Ninh Province, Vietnam
2. 173-25, Saneop-ro, Gwonseon-gu, Suwon-si, Gyeonggi- do, Korea (Suwon Industrial Complex)

3. Date of Receipt : Jun. 09, 2025

4. Test date : Jun. 14, 2025 ~ Jun. 16, 2025

5. Date of Issue : Jun. 24, 2025

6. Test Results : In Compliance

Tested by

Reviewed by

Hyo Jin, Kim
EMC Test Engineer

Dong Hun, Jang
EMC Technical Manager

This test report is not related to KS Q ISO/IEC 17025 and KOLAS.

**REPORT REVISION HISTORY**

Date	Test Report No.	Revision History
Jun. 24, 2025	KES-EM252060	Issued

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1.0 General Product Description

Main Specifications of EUT are:

Division		Specificity
Internal highest operating frequency		3 000 Mhz
Power	Rated Power	DC 5 V
	Test Power	AC 230 V, 50 Hz
Ports	I/O Port	RJ-12 1 EA
	Unused Port	N/A
Components		Main Body 1 EA, Cable 1 EA



Video	
Imaging Device	1/2.8" CMOS
Resolution	None
Max. Framerate	None
NETD	None
Pixel Size	None
Video Out	None
Video Transmission Distance	None
Lens	
Focal Length (Zoom Ratio)	4.72mm fixed focal
Optical Zoom	None
Max. Aperture Ratio	F2.07
Angular Field of View	H: 70°, V: 50°, D: 96°
Min. Object Distance	0.5m(1.64ft)
Focus Control	Fixed
Lens Type	None
Mount Type	RJ12 connected with main unit
Optional Lens	None
Environmental & Electrical	
Operating Temperature / Humidity	-10°C~+55°C(+14°F~+131°F) / 0~95%RH(non-condensing)
Storage Temperature / Humidity	-50°C~+60°C(-58°F~+140°F) / 0~90% RH
Wind Load	None
EPA(Effective Projected Area)	None
Certification	None
Input Voltage	DC 5V/0.25A
Power Consumption	1.25W
Mechanical	
Color / Material	Black / Plastic
RAL Code	RAL9005
Product Dimensions / Weight	Lens: ø24x44.9mm(ø0.94x1.77"), 34.2g(0.08lb) Cable: 8m(26.2ft)
Compatible Conduit hole / Gang	None
Certifications & Standards	
Network	None
EMC	FCC 47 CFR 15 Subpart B Class A ICES-3(A)/NMB-3(A) CE/UKCA - EN 55032 Class A, EN 50130-4, EN 61000-3-2, EN 61000-3-3 VCCI CISPR 32 Class A RCM AS/NZS CISPR 32 Class A KS C 9832 Class A , KS C 9835
Safety	UL 62368-1, CAN/CSA C22.2 NO. 62368-1
Video	None



1.1 Test Voltage & Frequency

Unless indicated otherwise on the individual data sheet or test results, the test voltage and frequency was as indicated below.

☒ AC 230 V, 50 Hz

1.2 Variant Model Differences

Not applicable

1.3 Device Modifications

Not applicable

1.4 Equipment Under Test

Description	Model Number	Serial Number	Manufacturer	Remarks
LENS MODULE	SLA-F4780A	-	HANWHA VISION VIETNAM COMPANY LIMITED	EUT

1.5 Support Equipments

Description	Model Number	Serial Number	Manufacturer	Remarks
NETWORK CAMERA Adapter	2ACB022F	-	Channel Well Technology (Guangzhou) Co., Ltd.	-
NETWORK CAMERA	PNM-C20000QB	-	HANWHA VISION VIETNAM COMPANY LIMITED	-
Laptop	LG15U56	605NZ8J002174	LG Electronics Inc.	-
Laptop Adatper	ADS-65AI-19-3	EAY65689605	SHENZHEN HONOR ELECTRONIC CO.,LTD.	-

1.6 External I/O Cabling

Start		END		Cable Spec.	
Description	I/O Port	Description	I/O Port	Length	Shield
LENS MODULE (EUT)	RJ-12	NETWORK CAMERA	RJ-12	8.0	S
Laptop	DC Jack	Laptop Apapter	DC Jack	1.4	S
	RJ-45	NETWORK CAMERA	RJ-45	1.5	U
NETWORK CAMERA	DC IN	Laptop Adatper	2 Pin	1.2	U

* Unshielded=U, Shielded=S

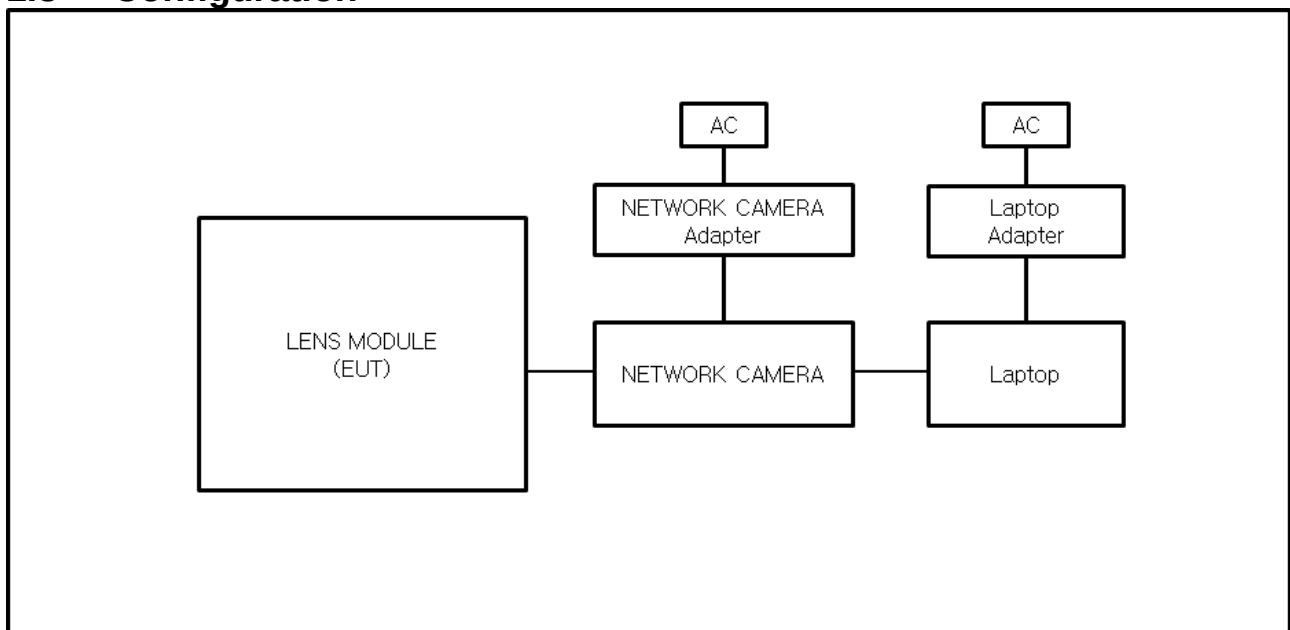


1.7 EUT Operating Mode(s)

- Check the network behavior of the EUT with the laptop's ping test.
- View images of the camera through the Web Viewer.

EUT Test operating S/W		
Name	Version	Manufacture Company
Web Viewer	-	HANWHA VISION VIETNAM COMPANY LIMITED

1.8 Configuration



**1.9 Remarks when standards applied**

N/A

1.10 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less.

1.11 Test Facility

The measurement facility is located at 473-21, Gayeo-ro, Yeosu-si, Gyeonggi-do, 12658, Korea, Republic of. The sites are constructed in conformance with the requirements of ANSI C63.4a-2017 and CISPR 16-1-4:2019

1.12 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
KOREA	RRA	EMI (3 m & 10 m Semi-Anechoic Chamber and conducted test site) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and interruptions)	 KR0100
International	KOLAS	EMI (3 m & 10 m Semi-Anechoic Chamber and conducted test site) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and interruptions)	 KT489
USA	FCC	3 m & 10 m Semi-Anechoic Chamber Conducted test site to perform FCC Part 15/18 measurements.	 KR0100
Canada	ISED	3 m & 10 m Semi-Anechoic Chamber and Conducted test site	 23298
JAPAN	VCCI	EMI (3 m & 10 m Semi-Anechoic Chamber and conducted test site)	 C-20136, T-20137, R-20181, G-20176
Europe	TÜV SÜD	EMI (3 m & 10 m Semi-Anechoic Chamber and conducted test site) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and interruptions)	 CARAT 001633 0008



2.0 Test Regulations

The emissions tests were performed according to following regulations:

☒ **EMC – Directive 2014/30/EU**

☒ EN 55032:2015/A1:2020

☒ Class A

☐ Class B

☒ EN 50130-4:2011/A1:2014

☒ EN IEC 61000-3-2:2019

☒ EN 61000-3-3:2013/A2:2021

☒ **EMC – Regulations 2016**

☒ EN 55032:2015/A1:2020

☒ Class A

☐ Class B

☒ EN 50130-4:2011/A1:2014

☒ EN IEC 61000-3-2:2019

☒ EN 61000-3-3:2013/A2:2021



2.1 Conducted Emissions at Mains Power Ports

Test Date

Jun. 14, 2025

Test Location

Electro wave Shieldroom #6

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMI Test SW	EMC32	R & S	9.12.00	-
☒	EMI TEST RECEIVER	ESR3	R & S	101783	11, 06, 2025
☒	LISN	ENV216	R & S	101786	01, 09, 2026
☒	ARTIFICIAL MAINS NETWORK	ESH2-Z5	R & S	100450	11, 06, 2025
☒	PULSE LIMITER	ESH3-Z2	R & S	101915	11, 06, 2025

Test Conditions

Temperature: (23,4 ± 0,1) °C

Relative Humidity: (46,5 ± 0,1) % R.H.

Frequency Range of Measurement

150 kHz to 30 MHz

Instrument Settings

IF Band Width: 9 kHz

Test Results

The requirements are:

- ☒ PASS
☐ NOT PASS
☐ NOT APPLICABLE

RemarksSee Appendix A for test data.



2.2 Conducted Emissions at Telecommunication Ports

Test Date

N/A

Test Location

Electro wave Shieldroom #6

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☐	EMI Test S/W	EMC32	R & S	9.12.00	-
☐	EMI TEST RECEIVER	ESR3	R & S	101783	11, 06, 2025
☐	LISN	ENV216	R & S	101786	01, 09, 2026
☐	ARTIFICIAL MAINS NETWORK	ESH2-Z5	R & S	100450	11, 06, 2025
☐	PULSE LIMITER	ESH3-Z2	R & S	101915	11, 06, 2025
☐	8-WIRE ISN CAT6	NTFM 8158	SCHWARZBECK	8158-0029	01, 09, 2026

Test Conditions

Temperature: (±) °C

Relative Humidity: (±) % R.H.

Frequency Range of Measurement

150 kHz to 30 MHz

Instrument Settings

IF Band Width: 9 kHz

Test Results

The requirements are:

- ☐ PASS
☐ NOT PASS
☒ NOT APPLICABLE

RemarksNot tested because there is no communication port.



2.3 Radiated Electric Field Emissions(Below 1 GHz)

Test Date

Jun. 14, 2025

Test Location☒ SEMI ANECHOIC CHAMBER #4(10m)**Test Equipment**

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMI Test S/W	EP5/RE	TOYO Corporation	6.0.0	-
☒	EMI TEST RECEIVER	ESU26	R & S	100551	02, 13, 2026
☒	AMPLIFIER	SCU 01	R & S	100603	11, 06, 2025
☒	BILOG ANTENNA	VULB 9168	SCHWARZBECK	9168-461	05, 09, 2026
☒	ATTENUATOR	6806.17.A	HUBER+SUHNER	-	02, 13, 2026

Test Conditions

Temperature: (23,4 ± 0,1) °C

Relative Humidity: (46,1 ± 0,1) % R.H.

Frequency Range of Measurement

30 MHz to 1 GHz

Instrument Settings

IF Band Width: 120 kHz

Test Results

The requirements are:

- ☒ PASS
☐ NOT PASS
☐ NOT APPLICABLE

RemarksSee Appendix A for test data.



2.4 Radiated Electric Field Emissions(Above 1 GHz)

Test Date

Jun. 15, 2025

Test Location

SEMI ANECHOIC CHAMBER #5

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMI Test SW	ES10/RE	TOYO Corporation	2022.01.000	-
☒	EMI TEST RECEIVER	ESU26	Rohde & Schwarz	100552	02, 13, 2026
☒	HORN ANTENNA	BBHA 9120D	SCHWARZBECK	9120D-1802	11, 04, 2025
☒	PREAMPLIFIER	8449B	HP	3008A00538	04, 30, 2025
☒	ATTENUATOR	8491B	HP	23094	02, 13, 2026

Test Conditions

Temperature: (23,1 ± 0,1) °C

Relative Humidity: (46,1 ± 0,1) % R.H.

Frequency Range of Measurement

1 GHz to 6 GHz

Instrument Settings

IF Band Width: 1 MHz

Test Results

The requirements are:

- ☒ PASS
☐ NOT PASS
☐ NOT APPLICABLE

Remarks

- See Appendix A for test data.
- The Average of the test data is the cispr average result.



2.5 Harmonic Current Emissions

Test Date

Jun. 14, 2025

Test Location

Electro wave Shieldroom #7

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMI Test SW	net.control	EM TEST	2.1.4	-
☒	DIGITAL POWER ANALYZER	DPA 500N	EM TEST	V1024106759	03, 31, 2026
☒	POWER SOURCE	ACS 500N6	EM TEST	V1024106760	-

Test Conditions

Temperature: (22,8 ± 0,1) °C

Relative Humidity: (46,4 ± 0,1) % R.H.

Classification of Equipment for Harmonic Current Emissions

- ☒ Class A
- ☐ Class B
- ☐ Class C(Below 25 W)
- ☐ Class C(Above 25 W)
- ☐ Class D

Test Results

The requirements are:

- ☒ PASS
- ☐ NOT PASS
- ☐ NOT APPLICABLE

RemarksSee Appendix A for test data.



2.6 Voltage Fluctuations and Flicker

Test Date

Jun. 14, 2025

Test Location

Electro wave Shieldroom #7

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMI Test SW	net.control	EM TEST	2.1.4	-
☒	DIGITAL POWER ANALYZER	DPA 500N	EM TEST	V1024106759	03, 31, 2026
☒	POWER SOURCE	ACS 500N6	EM TEST	V1024106760	-

Test Conditions

Temperature: (22,8 ± 0,1) °C

Relative Humidity: (46,4 ± 0,2) % R.H.

Test Results

The requirements are:

- ☒ PASS
☐ NOT PASS
☐ NOT APPLICABLE

RemarksSee Appendix A for test data.



3.0 Criteria for compliance

Criteria for compliance was based on the following guidelines:

EN 50130-4:2011/A1 :2014 Alarm systems-Part 4: Electromagnetic compatibility Product family standard:

Immunity requirements for components of fire, intruder and social alarm systems

The variety and the diversity of the apparatus within the scope of this document makes it difficult to define precise criteria for the evaluation of the immunity test results.

If as a result of the application of the tests defined in this standard, the apparatus

becomes dangerous or unsafe then the apparatus shall be deemed to have failed the test.

A functional description and a definition of performance by the manufacture and noted in the test report, based on the following criteria:

Electrostatic discharge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing that is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

Radiated electromagnetic fields

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing which could be interpreted by associated equipment as a change, and no such

Flickering of indicators occurs at a field strength of 3 V/m .

For components of CCTV systems, where the picture is allowed at 10 V/m , providing.

(a) there is no permanent damage or change to EUT

(e.g. no corruption of memory or changes to programmable setting etc.)

(b) at 3 V/m , any deterioration of the picture is so minor that the system could still be used; and

(c) there is no observable deterioration of the picture at 1 V/m .



Fast transient burst / slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing

That there is no residual is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

Conducted RF immunity

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing

That there is no residual is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators oeuvres at $U = 130 \text{ dB}\mu\text{V}$.

For component of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at $U = 140 \text{ dB}\mu\text{V}$, providing:

- (a) there is no permanent damage or change to the EUT
(e.g. no corruption of memory or changes to programmable settings etc.)
- (b) at $U = 130 \text{ dB}\mu\text{V}$, any deterioration of the picture is so minor that the system could still be used; and
- (c) there in no observable deterioration of the picture at $U = 120 \text{ dB}\mu\text{V}$.

Voltage dip/interruption / Voltage variation

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test, after the conditioning.



3.1 Electrostatic Discharge

Reference Standard

EN 61000-4-2

Test Date

Jun. 15, 2025

Test Location

EMS-ESD: Electro wave Shieldroom #6

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	ESD SIMULATOR	ESS-2000	Noise Ken	ESS01Z0454	01, 21, 2026
☒	HCP	-	KES	-	-
☒	VCP	-	Noise Ken	-	-

Test Conditions

Temperature: (23,3 ± 0,1) °C
Relative Humidity: (46,3 ± 0,1) % R.H.
Atmospheric Pressure: (100,2 ± 0,1) kPa

Test Specifications

Discharge Factor: ≥ 1 s
Discharge Impedance: 330 ohm / 150 pF
Kind of Discharge: Air, Contact (direct and indirect)
Polarity: Positive and Negative
Number of Discharge: 10 at all locations for Air discharge
10 at all locations for Contact discharge

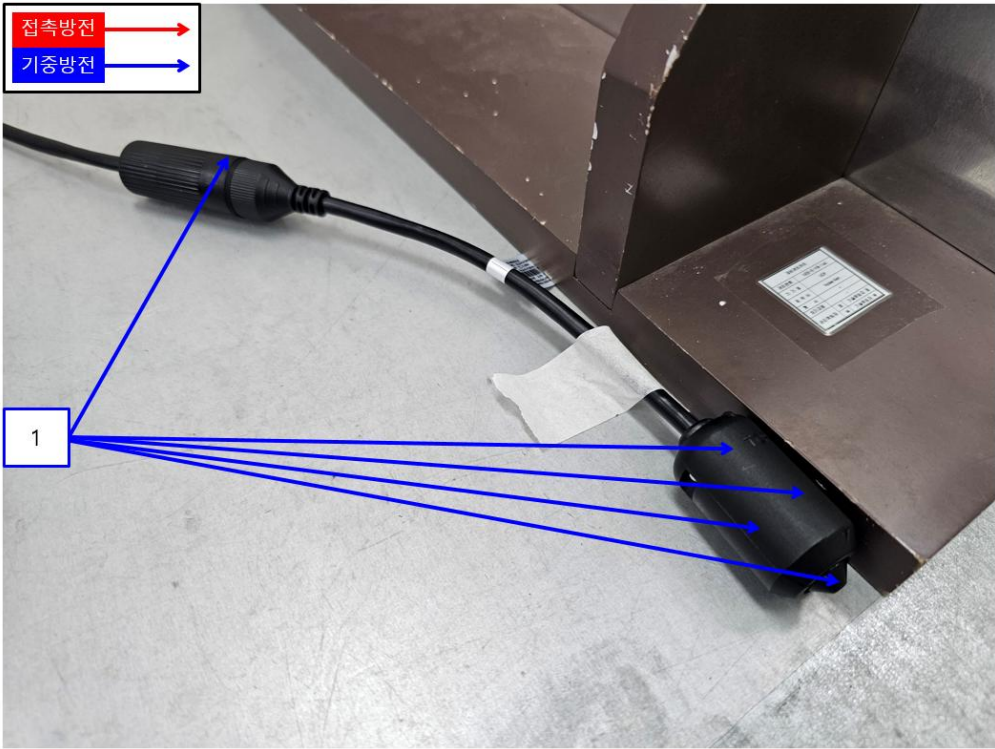
Discharge Voltage:	Contact	Air	HCP	VCP
	☐ 2 kV	☒ 2 kV	☐ 2 kV	☐ 2 kV
	☐ 4 kV	☒ 4 kV	☐ 4 kV	☐ 4 kV
	☒ 6 kV	☐ 6 kV	☒ 6 kV	☒ 6 kV
	☐ 8 kV	☒ 8 kV	☐ 8 kV	☐ 8 kV
	☐ 15 kV	☐ 15 kV	☐ 15 kV	☐ 15 kV

Notes: HCP: Horizontal coupling plane
VCP: Vertical coupling plane

Required Performance Criteria: ☒ Complied



Location of Discharge:



**Test Data**

No.	Test Point	Discharge Method	Observations	Remarks
1	HCP Contact	Contact Discharge	Complied	-
2	VCP Contact	Contact Discharge	Complied	-

Direct Discharge

No.	Test Point	Discharge Method	Observations	Remarks
1	Enclosure, Lens	Air Discharge	Complied	-

Note: "Blank" = Not performed

Observations:

Complied – No degradation of function

Test Results

- ☒ PASS Required Performance Criteria
☐ NOT PASS Required Performance Criteria

Remarks

PASS Required Performance Criteria



3.2 Radiated Electric Field Immunity

Reference Standard

EN IEC 61000-4-3

Test Date

Jun. 16, 2025

Test LocationEMS-RS: ☒ SEMI ANECHOIC CHAMBER #3☐ SEMI ANECHOIC CHAMBER #4(10 m)**Test Equipment**

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	EMC32	R & S	10.10.02	-
☒	SIGNAL GENERATOR	SMB 100A	Rohde & Schwarz	108252	07, 29, 2025
☒	HIGH POWER DUAL AMP	SSA532	SUNGSAN	SSA532-001	-
☒	POWER METER	E4419B	Agilent	GB40203000	02, 13, 2026
☒	AVERAGE POWER SENSOR	E9301A	Agilent	MY52170007	02, 13, 2026
☒	AVERAGE POWER SENSOR	E9301A	Agilent	MY41498669	02, 13, 2026
☒	STACKED DOUBLE LOG-PER- ANTENNA	STPL9128 E	Schwarzbeck	9128ES-121	-
☒	DOUBLE RIDGED HORN ANTENNA	SAS-571	A.H.SYSTEM,INC	781	03, 05, 2026

Test Conditions

Temperature: (22,9 ± 0,1) °C
Relative Humidity: (45,7 ± 0,1) % R.H.
Atmospheric Pressure: (99,8 ± 0,1) kPa



Test Specifications

Antenna Polarization: Horizontal & vertical unless indicated otherwise

Antenna Distance: ☒ 3 m

Field Strength: ☐ 1 V/m ☐ 3 V/m
☒ 10 V/m

Frequency Range: ☐ 80 MHz to 1 GHz ☐ 1,4 GHz to 2,7 GHz
☒ 80 MHz to 2,7 GHz

Modulation: ☒ AM, 80 %, 1 kHz sine wave
☒ PM, 1 Hz (0,5 s ON : 0,5 s OFF)

Frequency step: ☒ 1 % step

Dwell Time: ☐ 1 s ☒ 3 s

of Sides Radiated: ☒ 4

Required Performance Criteria: ☒ Complied

**Test Data**

Side Exposed	Observations	
	Horizontal	Vertical
Front	Complied	Complied
Right	Complied	Complied
Back	Complied	Complied
Left	Complied	Complied

Note: "Blank" = Not performed

Observations:

Complied – No degradation of function

Test Results

- ☒ PASS Required Performance Criteria
☐ NOT PASS Required Performance Criteria

Remarks

PASS Required Performance Criteria



3.3 Electrical Fast Transients/Bursts

Reference Standard

EN 61000-4-4

Test Date

Jun. 16, 2025

Test Location

EMS-EFT: Electro wave Shieldroom #7

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	iec.control	EM TEST	5.4.8	-
☒	ULTRA COMPACT SIMULATOR	UCS 500N7	EM TEST	P1608172950	11, 06, 2025
☒	MOTOR VARIAC	MV2616	EM TEST	P1552169719	11, 07, 2025
☒	CAPACITIVE COUPLING CLAMP	HFK	EM TEST	P1633183115	11, 06, 2025

Test Conditions

Temperature: (23,1 ± 0,2) °C
Relative Humidity: (46,2 ± 0,2) % R.H.
Atmospheric Pressure: (100,1 ± 0,1) kPa

Test Specifications

Pulse Amplitude & Polarity: ☐ ± 1.0 kV ☒ ± 2.0 kV
(AC Power Lines) ☐ ± 4.0 kV

Pulse Amplitude & Polarity: ☐ ± 0.5 kV ☒ ± 1.0 kV
(Other supply / Signal Lines) ☐ ± 2.0 kV

Burst Period: ☒ 300 ms ☐ 2 s

Repetition Rate: ☐ 5 kHz ☒ 100 kHz

Duration of Test Voltage: ☒ ≥ 1 min

Required Performance Criteria: ☒ Complied

**Test Data**☒ Input a.c. power ports – Coupling/Decoupling Network used

Mode of Application	Observations	
	(+) Burst (kV)	(-) Burst (kV)
L	Complied	Complied
N	Complied	Complied
L – N	Complied	Complied

☐ Input d.c. power ports – Coupling/Decoupling Network used

Mode of Application	Observations	
	(+) Burst (kV)	(-) Burst (kV)
-	-	-

☒ Signal ports and telecommunication ports – Coupling Clamp used

Mode of Application	Observations	
	(+) Burst (kV)	(-) Burst (kV)
RJ-12	Complied	Complied

Note: “Blank” = Not performed

Observations:

Complied – No degradation of function

Test Results☒ PASS Required Performance Criteria☐ NOT PASS Required Performance Criteria**Remarks**PASS Required Performance Criteria



3.4 Surge Transients

Reference Standard

EN 61000-4-5

Test Date

Jun. 16, 2025

Test Location

EMS-Surge: Electro wave Shieldroom #7

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	iec.control	EM TEST	5.4.8	-
☒	ULTRA COMPACT SIMULATOR	UCS 500N7	EM TEST	P1608172950	11, 07, 2025
☒	MOTOR VARIAC	MV2616	EM TEST	P1552169719	11, 07, 2025

Test Conditions

Temperature: (23,1 ± 0,1) °C
Relative Humidity: (46,2 ± 0,1) % R.H.
Atmospheric Pressure: (100,1 ± 0,1) kPa



Test Specifications

AC Power Lines

Source Impedance: 12 ohm for common Mode and 2 ohm for differential Mode

Surge Amplitude :
Common Mode
☐ (0,5 / 1,0 / 2,0) kV
Differential Mode
☒ (0,5 / 1,0) kV

Number of Surges: ☒ 5 surges per angle

Angle: ☒ 0°, 90°, 180°, 270° (input a.c. power port)

Polarity: ☒ Positive & Negative

Repetition Rate: ☐ 1 surge per min ☒ 1 surge per 30 sec.

Required Performance Criteria: ☒ Complied

Other supply / Signal Lines

Source Impedance: 42 ohm for common Mode

Surge Amplitude: Common Mode
☐ (0,5 / 1,0) kV

Number of Surges: ☐ 5 Surges

Polarity: ☐ Positive & Negative

Repetition Rate: ☐ 1 surge per min ☐ 1 surge per 30 sec.

Required Performance Criteria: ☐ Complied

**Test Data**☒ Line to Line – Differential Mode

Mode of Application	Observations	
	(+) Surge (kV)	(-) Surge (kV)
L – N	Complied	Complied

☐ Line to Earth – Common Mode

Mode of Application	Observations	
	(+) Surge (kV)	(-) Surge (kV)
-	-	-

Signal Lines☐ Line to Earth – Common Mode

Mode of Application	Coupling Method	Observations	
		(+) Surge (kV)	(-) Surge (kV)
-	CDN	-	-
	LINE	-	-

Note: "Blank" = Not performed

Observations:

Complied – No degradation of function

Test Results☒ PASS Required Performance Criteria☐ NOT PASS Required Performance Criteria**Remarks**PASS Required Performance Criteria



3.5 Conducted Disturbance

Reference Standard

EN 61000-4-6

Test Date

Jun. 16, 2025

Test Location

EMS-CS: Electro wave Shieldroom #7

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	icd.control	EM TEST	8.0.0	-
☒	TEST SYSTEM FOR CONDUCTED AND RADIATED	NSG4070	TESEQ	65585	11, 18, 2025
☒	ATTENUATOR	ATT 6/80	EM TEST	P1614178148	11, 06, 2025
☒	CDN	CDN M016	TESEQ	43694	11, 07, 2025
☒	CDN	CDN M016	TESEQ	43697	11, 07, 2025
☐	CDN	CDN T8RJ45	EM TEST	0909-09	07, 29, 2025
☒	EM CLAMP	KEMZ 801A	TESEQ	44099	11, 08, 2025

Test Conditions

Temperature: (23,1 ± 0,1) °C
Relative Humidity: (46,2 ± 0,1) % R.H.
Atmospheric Pressure: (100,1 ± 0,1) kPa

Test Specifications

Frequency range: ☒ 150 kHz to 100 MHz ☐ 150 kHz to 80 MHz

Voltage Level: ☐ 1 Vrms ☐ 3 Vrms
☒ 10 Vrms

Modulation: ☒ AM, 80 %, 1 kHz sine wave
☒ PM, 1 Hz (0,5 s ON : 0,5 s OFF)

Frequency step: ☒ 1 % step

Dwell Time: ☐ 1 s ☒ 3 s

Required Performance Criteria: ☒ Complied

**Test Data**☒ Input a.c. power ports

Coupling Location (Line Stressed)	Coupling Method	Observations
L – N	CDN	Complied

☐ Input d.c. power ports

Coupling Location (Line Stressed)	Coupling Method	Observations
-	-	-

☒ Signal ports and telecommunication ports

Coupling Location (Line Stressed)	Coupling Method	Observations
RJ-12	Clamp	Complied

Notes: CDN = Coupling Decoupling Network
"blank" = Not performed

Observations:
Complied – No degradation of function

Test Results

- ☒ PASS Required Performance Criteria
☐ NOT PASS Required Performance Criteria

Remarks

PASS Required Performance Criteria



3.6 Voltage Dips and Short Interruptions

Reference Standard

EN IEC 61000-4-11

Test Date

Jun. 16, 2025

Test Location

EMS-Voltage dip: Electro wave Shieldroom #7

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	iec.control	EM TEST	5.4.8	-
☒	ULTRA COMPACT SIMULATOR	UCS 500N7	EM TEST	P1608172950	11, 07, 2025
☒	MOTOR VARIAC	MV2616	EM TEST	P1552169719	11, 07, 2025

Test Conditions

Temperature: (23,1 ± 0,1) °C
Relative Humidity: (46,2 ± 0,1) % R.H.
Atmospheric Pressure: (100,1 ± 0,1) kPa

**Test Specifications & Observations/Remarks****- Voltage Dips and Short Interruptions**

<u>Test Level</u>	<u>Duration [in period/ms (50 Hz)]</u>	<u>Results</u>
☒ 20 % dip	☒ 250 / 5 000	<u>Complied</u>
☒ 30 % dip	☒ 25 / 500	<u>Complied</u>
☒ 60 % dip	☒ 10 / 200	<u>Complied</u>
☒ 100 % dip	☒ 250 / 5 000	<u>Degradation</u>

- Voltage variations

☒ Unom + 10 %	☒ 253.0 V (ac)	<u>Complied</u>
☒ Unom - 15 %	☒ 195.5 V (ac)	<u>Complied</u>

Observations:

Complied – No degradation of function

Degradation - See "Remarks "

Test Results

- ☒ PASS Required Performance Criteria
☐ NOT PASS Required Performance Criteria
☐ NOT APPLICABLE

Remarks

During the test(100%, 250cycle), EUT was turned off but after the test, it was recovered without operator's intervention.



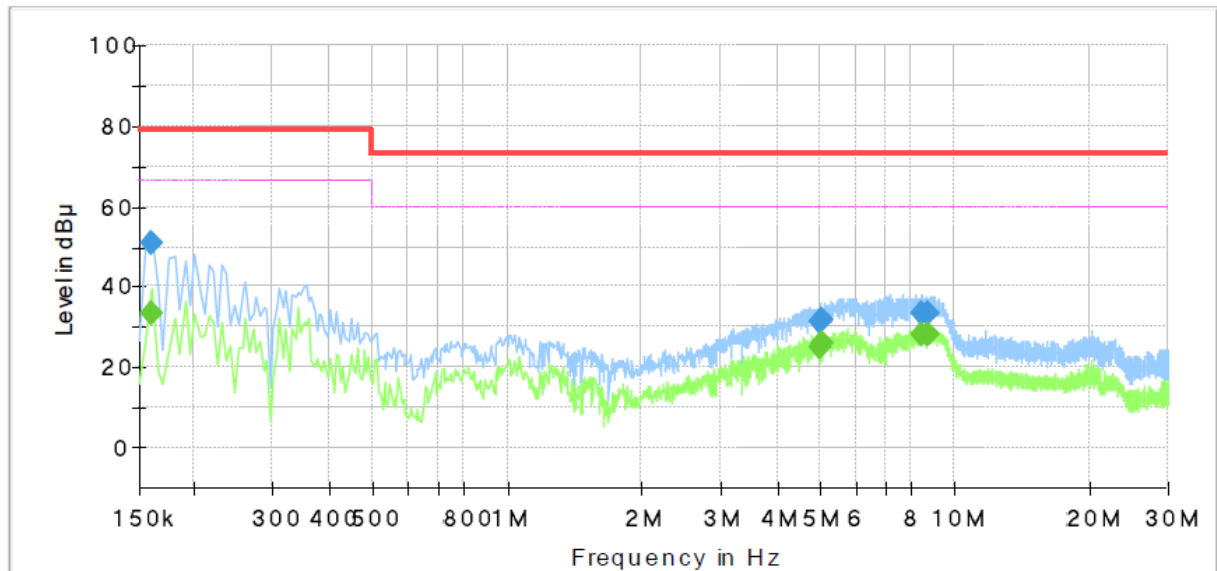
APPENDIX A – TEST DATA

Conducted Emissions at Mains Power Ports

[HOT]

Common Information

Test Description: Conducted Emission
Job No.: KES-EM252060
Phase: L
Mode:
Operator Name: KES



Final_Result

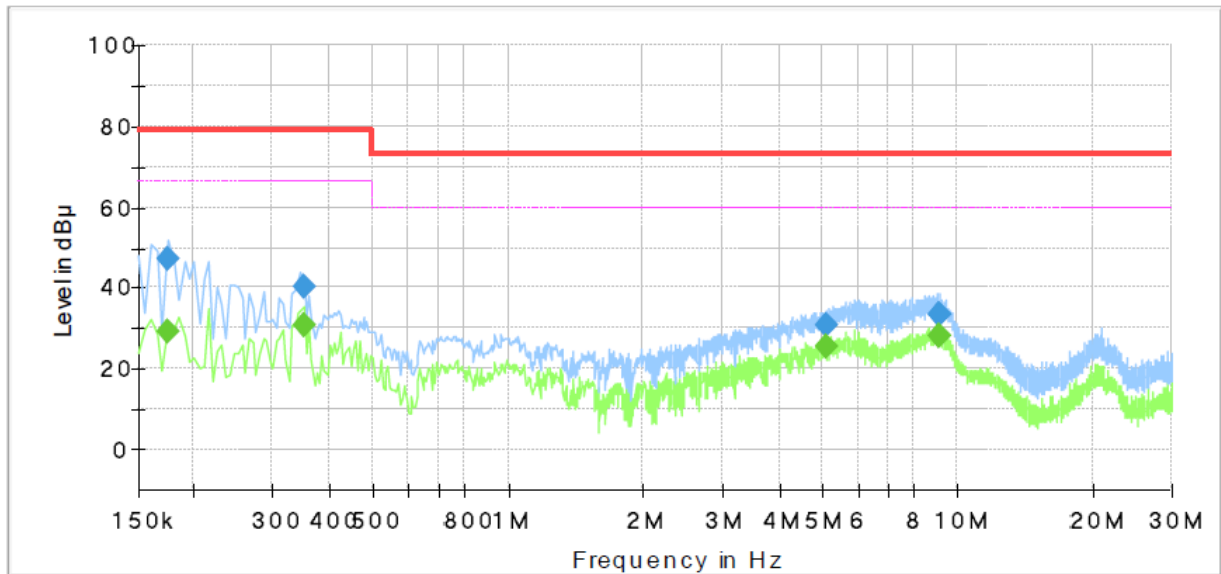
Frequency (MHz)	QuasiPeak (dBμV)	CAverage (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
0.160000	---	33.30	66.00	32.70	1000.0	9.000	L1	19.5
0.160000	50.93	---	79.00	28.07	1000.0	9.000	L1	19.5
4.985000	---	24.93	60.00	35.07	1000.0	9.000	L1	19.9
4.985000	31.00	---	73.00	42.00	1000.0	9.000	L1	19.9
5.070000	---	25.88	60.00	34.12	1000.0	9.000	L1	19.9
5.070000	31.71	---	73.00	41.29	1000.0	9.000	L1	19.9
8.405000	---	27.93	60.00	32.07	1000.0	9.000	L1	20.0
8.405000	33.38	---	73.00	39.62	1000.0	9.000	L1	20.0
8.750000	---	28.13	60.00	31.87	1000.0	9.000	L1	20.0
8.750000	33.50	---	73.00	39.50	1000.0	9.000	L1	20.0



[NEUTRAL]

Common Information

Test Description: Conducted Emission
Job No.: KES-EM252060
Phase: N
Mode:
Operator Name: KES



Final_Result

Frequency (MHz)	QuasiPeak (dBuV)	CAverage (dBuV)	Limit (dBuV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
0.175000	---	29.37	66.00	36.63	1000.0	9.000	N	19.5
0.175000	47.00	---	79.00	32.00	1000.0	9.000	N	19.5
0.350000	---	30.76	66.00	35.24	1000.0	9.000	N	19.5
0.350000	40.11	---	79.00	38.89	1000.0	9.000	N	19.5
5.115000	---	25.26	60.00	34.74	1000.0	9.000	N	19.9
5.115000	30.90	---	73.00	42.10	1000.0	9.000	N	19.9
9.115000	---	28.02	60.00	31.98	1000.0	9.000	N	20.0
9.115000	33.37	---	73.00	39.63	1000.0	9.000	N	20.0
9.145000	---	28.09	60.00	31.91	1000.0	9.000	N	20.0
9.145000	33.39	---	73.00	39.61	1000.0	9.000	N	20.0

◆ Calculation

QuasiPeak[dBuV] / CAverage [dBuV] = Reading Value[dBuV] + Corr. [dB]

QuasiPeak / CAverage : The Final Value

Reading Value : Not shown in the table.

Corr. : Correction values (LISN FACTOR + (Cable Loss + Pulse Limiter FACTOR))



Conducted Emissions at Telecommunication Ports

[1 000 Mbps]

N/A

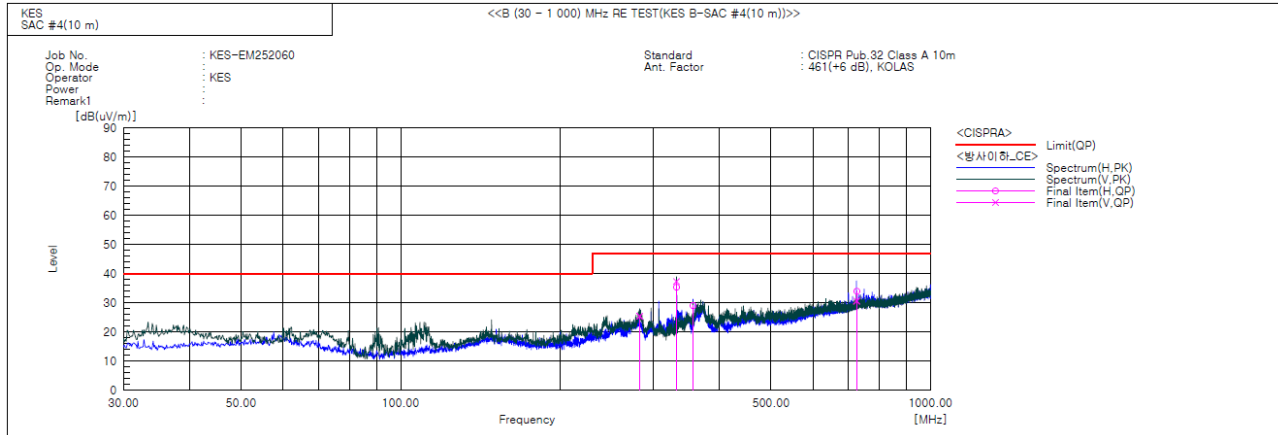
◆ Calculation

QuasiPeak[dBuV] / CAverage [dBuV] = Reading Value[dBuV] + Corr. [dB]

QuasiPeak / CAverage : The Final Value

Reading Value : Not shown in the table.

Corr. : Correction values (ISN FACTOR + (Cable Loss + Pulse Limiter FACTOR))

**Radiated Electric Field Emissions(Below 1 GHz)****Final Result**

No.	Frequency [MHz]	(P)	Reading QP [dB(μV)]	c.f [dB(1/m)]	Result QP [dB(μV/m)]	Limit QP [dB(μV/m)]	Margin QP [dB]	Height [cm]	Angle [deg]	Remark
1	282.564	V	43.1	-17.7	25.4	47.0	21.6	152.0	50.0	
2	331.413	V	53.3	-16.0	37.3	47.0	9.7	113.0	333.0	
3	331.791	H	51.3	-16.0	35.3	47.0	11.7	366.0	117.0	
4	356.284	H	44.3	-15.3	29.0	47.0	18.0	327.0	75.0	
5	725.215	V	34.9	-4.3	30.6	47.0	16.4	112.0	257.0	
6	725.851	H	38.1	-4.2	33.9	47.0	13.1	339.0	49.0	

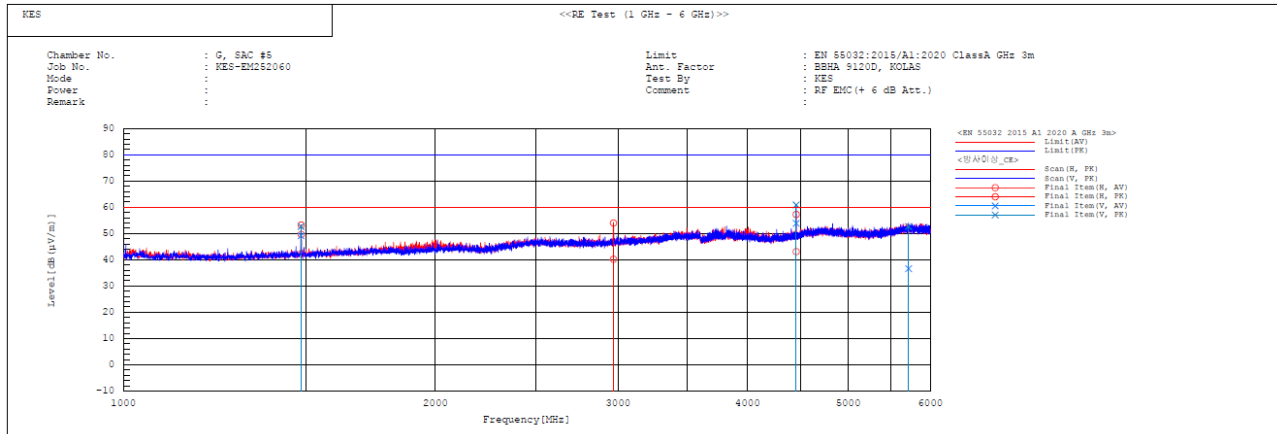
◆ Calculation

Result(QP) [dB(μV/m)] = (Reading(QP)[dB(μV)] + c.f[dB(1/m)])

Margin(QP)[dB] = Limit[dB(μV/m)] - Result(QP) [dB(μV/m)]

Reading(QP) : Reading value, Result(QP) : Reading value + Factor value

Limit(QP) : Limit value, c.f : (ANT Factor + Cable Loss - Preamp Factor), Margin: Margin value

**Radiated Electric Field Emissions(Above 1 GHz)****Final Result**

No.	Frequency [MHz]	Pol	Reading AV [dB(μV)]	Reading PK [dB(μV)]	c.f [dB(1/m)]	Result PK [dB(μV/m)]	Limit AV [dB(μV/m)]	Limit PK [dB(μV/m)]	Margin AV [dB]	Margin PK [dB]	Height [cm]	Angle [deg]	Remark
1	1484.274	V	48.1	51.7	1.0	52.7	60.0	80.0	10.9	27.3	100.0	45.6	
2	1484.542	H	48.6	52.2	1.0	53.2	60.0	80.0	10.4	26.8	100.0	24.2	
3	2969.894	H	33.9	47.7	6.3	54.0	60.0	80.0	19.8	26.0	100.0	355.7	
4	4454.841	H	32.4	46.6	10.7	57.3	60.0	80.0	16.9	22.7	100.0	204.0	
5	4455.124	V	43.2	50.2	10.7	60.9	60.0	80.0	6.1	19.1	100.0	162.8	
6	5718.214	V	22.7	38.8	13.9	52.7	60.0	80.0	23.4	27.3	100.0	237.9	

◆ Calculation

Result(PK/CAV) [dB(μV/m)] = (Reading(PK/CAV)[dB(μV)] + c.f[dB(1/m)]

Margin(PK/CAV)[dB] = Limit[dB(μV/m)] - Result(PK/CAV) [dB(μV/m)]

Reading(PK/CAV) : Reading value, Result(PK/CAV) : Reading value + Factor value

Limit(PK/CAV) : Limit value, c.f : (ANT Factor + Cable Loss - Preamp Factor), Margin: Margin value

**Harmonic Current Emissions and Voltage Fluctuations and Flicker**

Average harmonic current results				
Hn	I _{eff} [A]	% of Limit	Limit [A]	Result
1	0.052			
2	0.001	0.133	1.080	n/a
3	0.046	1.996	2.300	PASS
4	0.002	0.455	0.430	n/a
5	0.046	4.005	1.140	PASS
6	0.001	0.499	0.300	n/a
7	0.045	5.804	0.770	PASS
8	0.002	0.673	0.230	n/a
9	0.042	10.508	0.400	PASS
10	0.002	0.817	0.184	n/a
11	0.040	11.992	0.330	PASS
12	0.001	0.926	0.153	n/a
13	0.037	17.587	0.210	PASS
14	0.002	1.200	0.131	n/a
15	0.034	22.647	0.150	PASS
16	0.001	1.214	0.115	n/a
17	0.031	23.448	0.132	PASS
18	0.001	1.347	0.102	n/a
19	0.028	23.648	0.118	PASS
20	0.001	1.479	0.092	n/a
21	0.025	15.555	0.161	PASS
22	0.001	1.730	0.084	n/a
23	0.022	14.837	0.147	PASS
24	0.001	1.855	0.077	n/a
25	0.019	14.030	0.135	PASS
26	0.001	1.900	0.071	n/a
27	0.016	13.157	0.125	PASS
28	0.001	2.108	0.066	n/a
29	0.014	11.942	0.116	PASS
30	0.001	2.092	0.061	n/a
31	0.012	11.017	0.109	PASS
32	0.001	2.277	0.058	n/a
33	0.010	10.098	0.102	PASS
34	0.001	2.276	0.054	n/a
35	0.009	9.633	0.096	PASS
36	0.001	2.384	0.051	n/a
37	0.008	9.202	0.091	PASS
38	0.001	2.477	0.048	n/a
39	0.008	8.997	0.087	PASS
40	0.001	2.339	0.046	n/a

Note: Harmonic currents less than 0.6 % of the input current measured under the test conditions, or less than 5 mA, whichever is greater, are disregarded.

* Application of limits for average is 100% except for odd harmonics from 21 to 39, where 150% applies.



Test Data - Harmonics (continued)

Maximum harmonic current results

Hn	I _{eff} [A]	% of Limit	Limit [A]	Result
1	0.055			
2	0.002	0.123	1.620	n/a
3	0.049	1.408	3.450	PASS
4	0.002	0.378	0.645	n/a
5	0.048	2.803	1.710	PASS
6	0.002	0.467	0.450	n/a
7	0.046	4.018	1.155	PASS
8	0.002	0.519	0.345	n/a
9	0.044	7.358	0.600	PASS
10	0.002	0.658	0.276	n/a
11	0.042	8.388	0.495	PASS
12	0.002	0.688	0.230	n/a
13	0.038	12.166	0.315	PASS
14	0.002	0.922	0.197	n/a
15	0.035	15.621	0.225	PASS
16	0.002	0.926	0.173	n/a
17	0.032	16.162	0.199	PASS
18	0.002	0.998	0.153	n/a
19	0.029	16.181	0.178	PASS
20	0.002	1.106	0.138	n/a
21	0.025	15.853	0.161	PASS
22	0.002	1.322	0.125	n/a
23	0.022	15.046	0.147	PASS
24	0.002	1.370	0.115	n/a
25	0.019	14.110	0.135	PASS
26	0.002	1.485	0.106	n/a
27	0.017	13.235	0.125	PASS
28	0.002	1.582	0.099	n/a
29	0.014	12.092	0.116	PASS
30	0.001	1.588	0.092	n/a
31	0.012	11.161	0.109	PASS
32	0.001	1.716	0.086	n/a
33	0.010	10.232	0.102	PASS
34	0.001	1.840	0.081	n/a
35	0.010	9.940	0.096	PASS
36	0.001	1.918	0.077	n/a
37	0.009	9.588	0.091	PASS
38	0.001	1.877	0.073	n/a
39	0.008	9.547	0.087	PASS
40	0.001	2.032	0.069	n/a

Note: Harmonic currents less than 0.6 % of the input current measured under the test conditions, or less than 5 mA, whichever is greater, are disregarded.

* Application of limits for average is 100% except for odd harmonics from 21 to 39, where 150% applies.



Test Data - Voltage Fluctuations

Maximum Flicker results

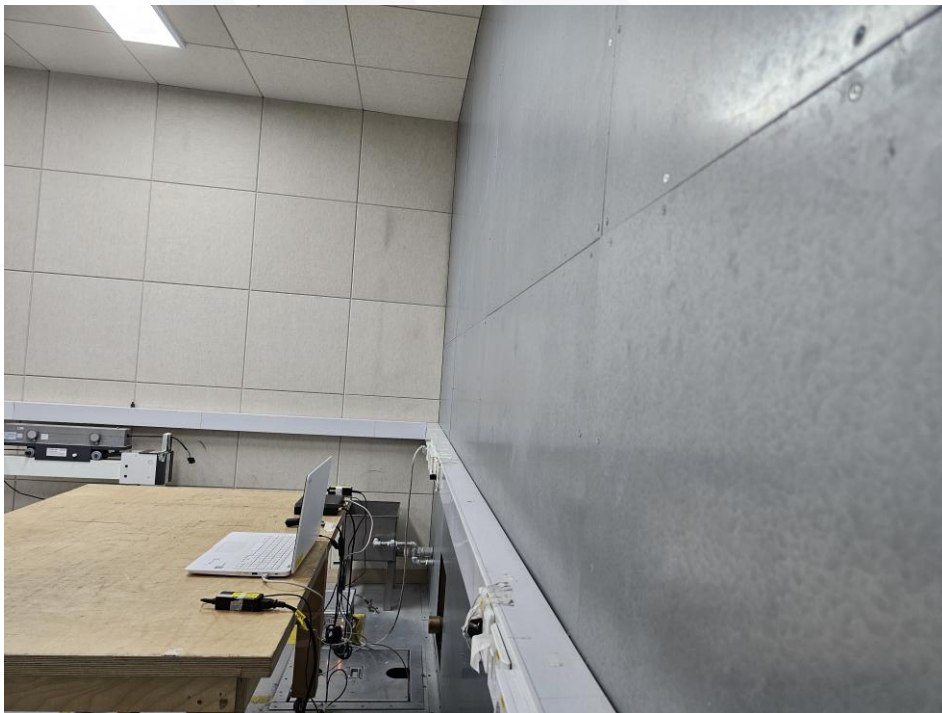
Flicker Measurements					
	Plt	Max Pst	Max Dc	Max Dmax	Max Tmax
Line 1:	0.028	0.028	0	< 0.2	0
Limits:	0.65	1	3.3	4	0.5
Results:	PASS	PASS	PASS	PASS	PASS





Test Setup Photos and Configuration

Conducted Emissions at Mains Power Ports





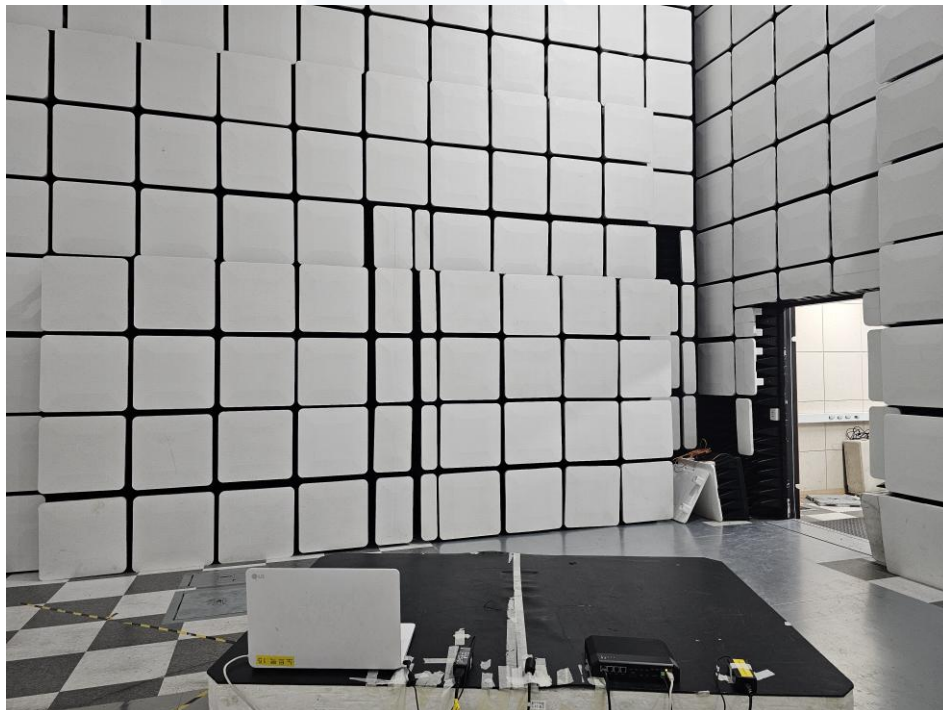
Conducted Emissions at Telecommunication Ports

N/A



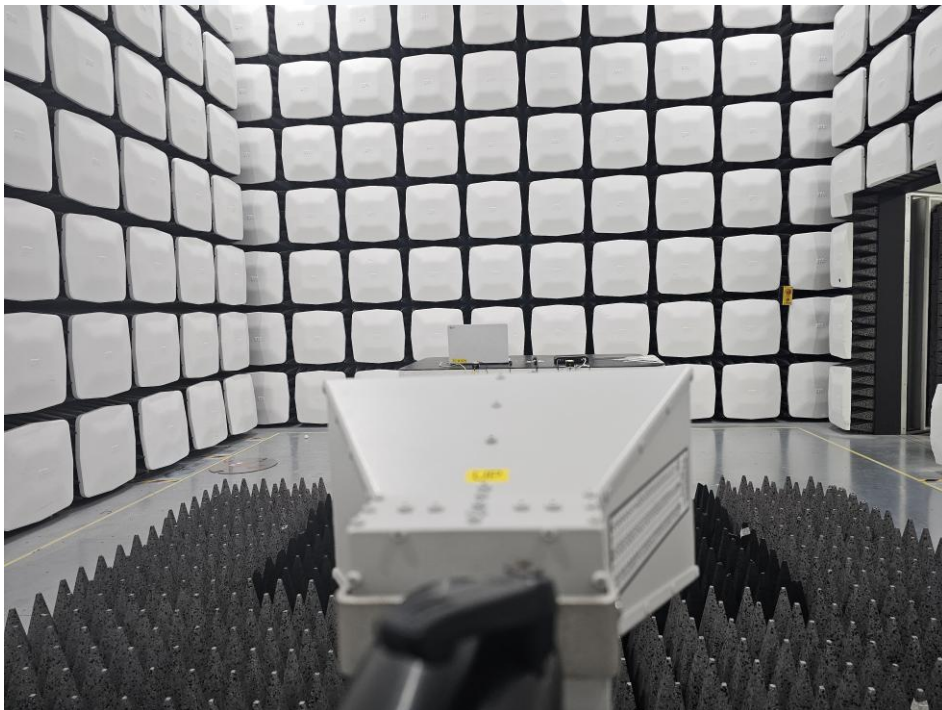
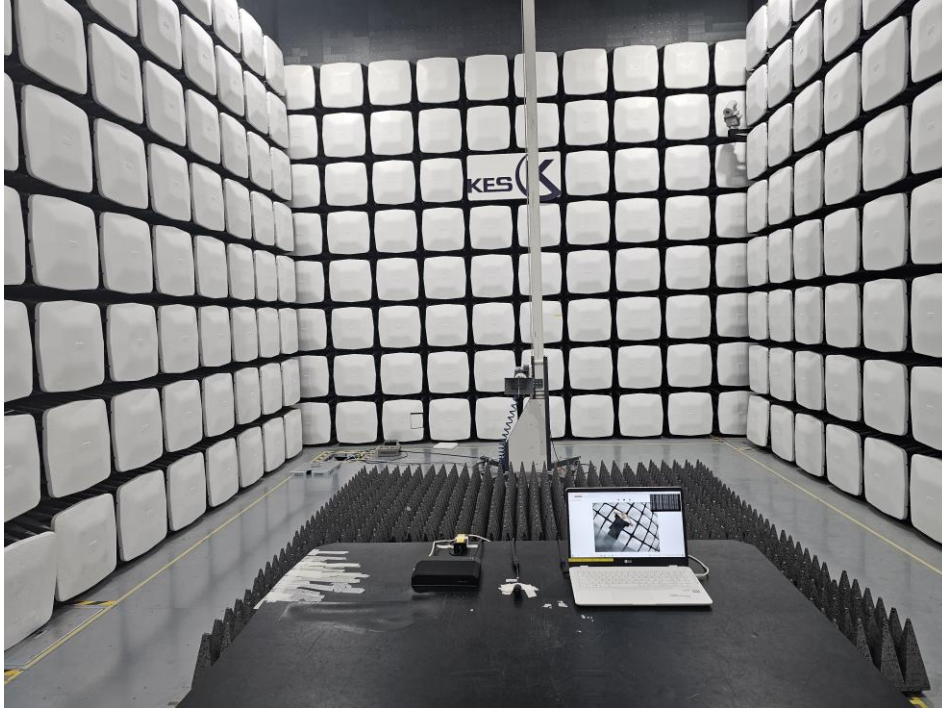


Radiated Electric Field Emissions(Below 1 GHz)





Radiated Electric Field Emissions(Above 1 GHz)





Harmonic Current Emissions and Voltage Fluctuations and Flicker

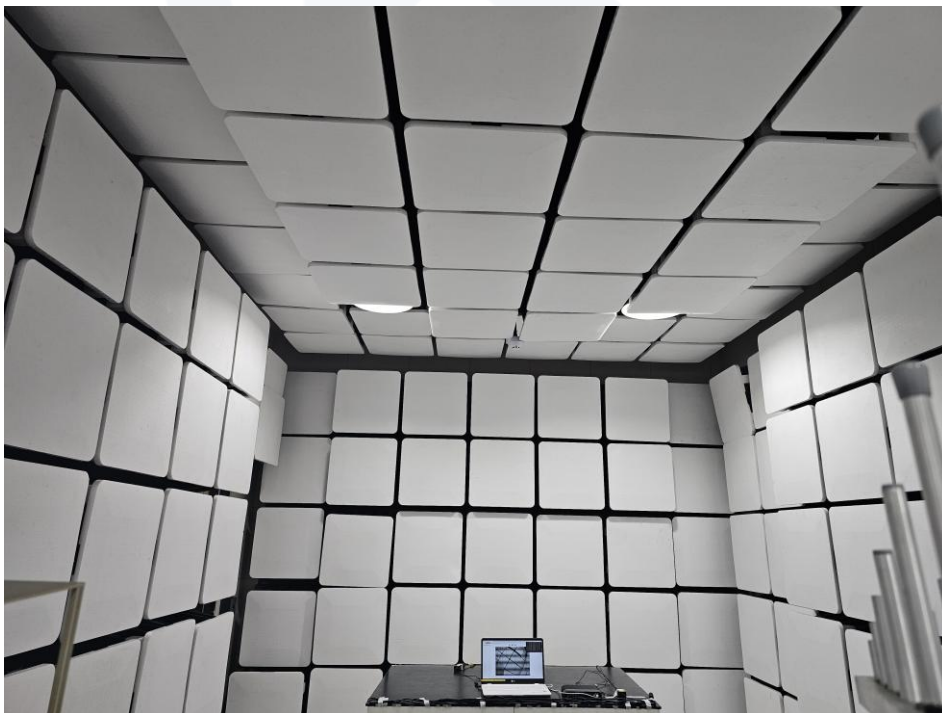




Electrostatic Discharge



Radiated Electric Field Immunity





Electrical Fast Transients/Bursts

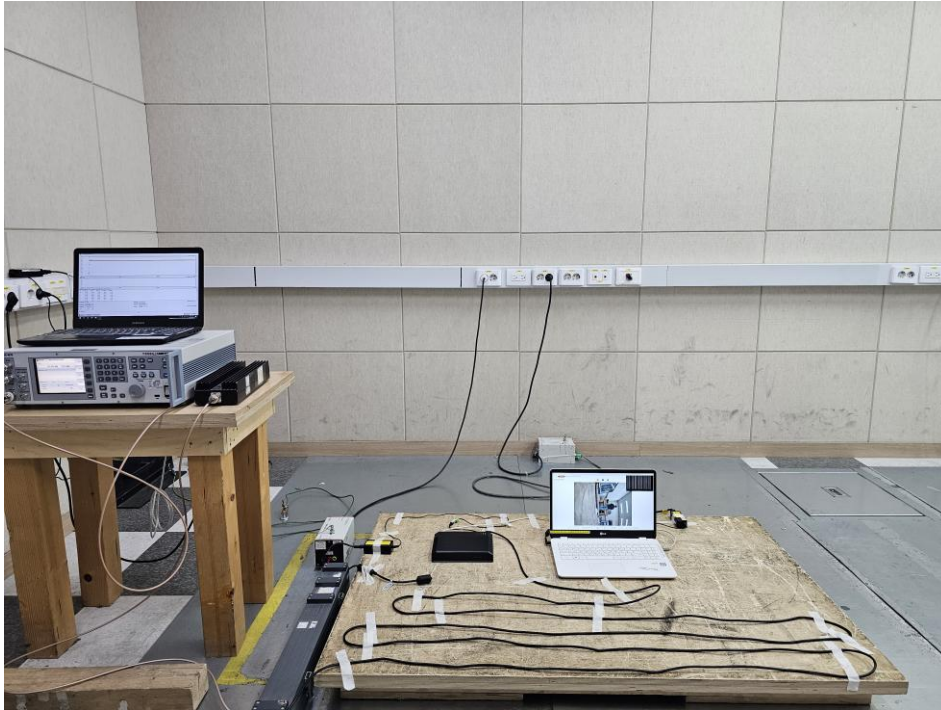


Surge Transients





Conducted Disturbance



Voltage Dips and Short Interruptions





EUT External Photographs

(Top)



(Bottom)





(Component)





EUT Internal Photographs

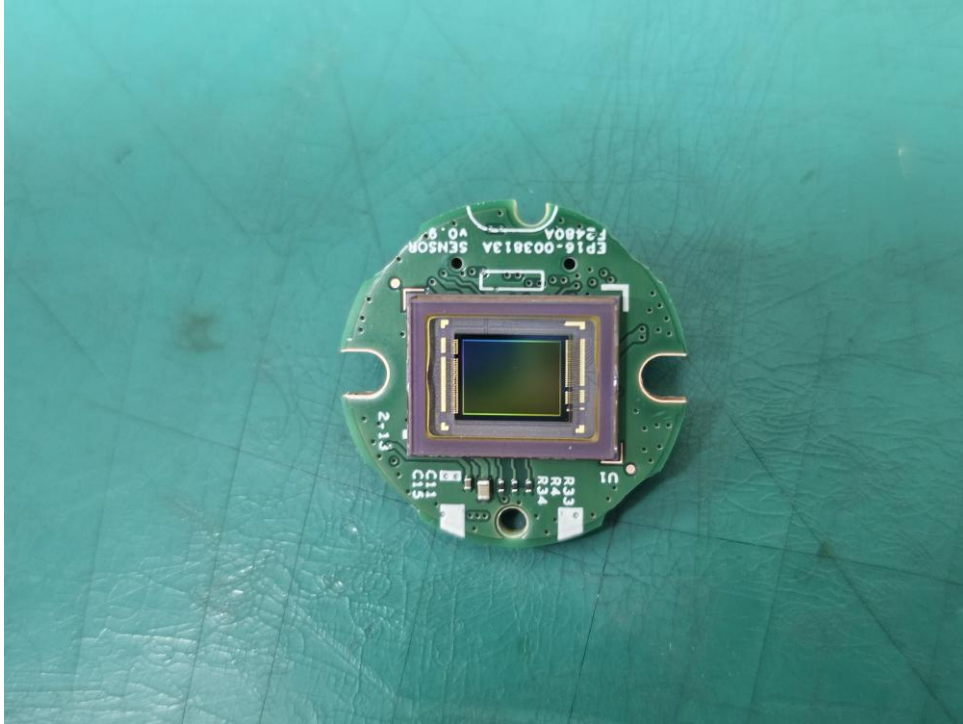
(Internal View)



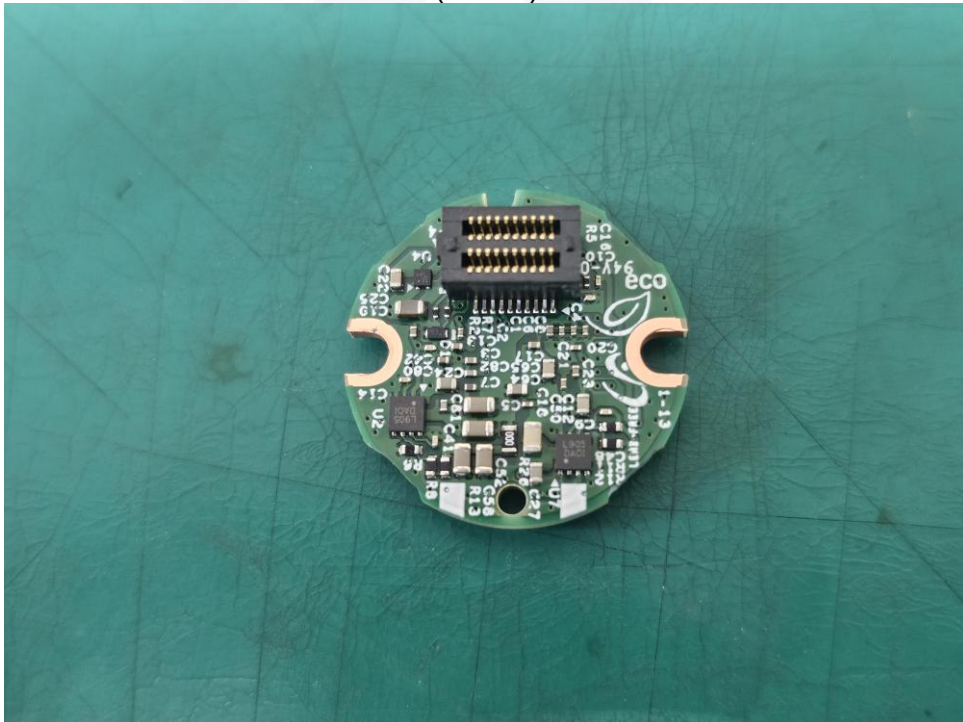


EUT Internal View – Board 1

(Top)



(Bottom)



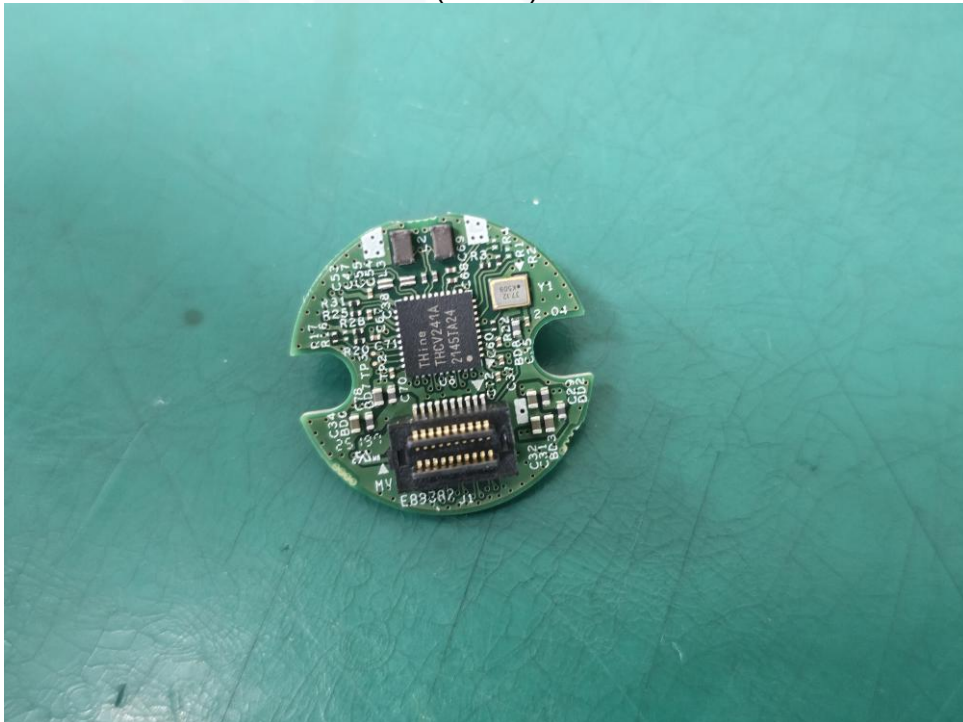


EUT Internal View – Board 2

(Top)

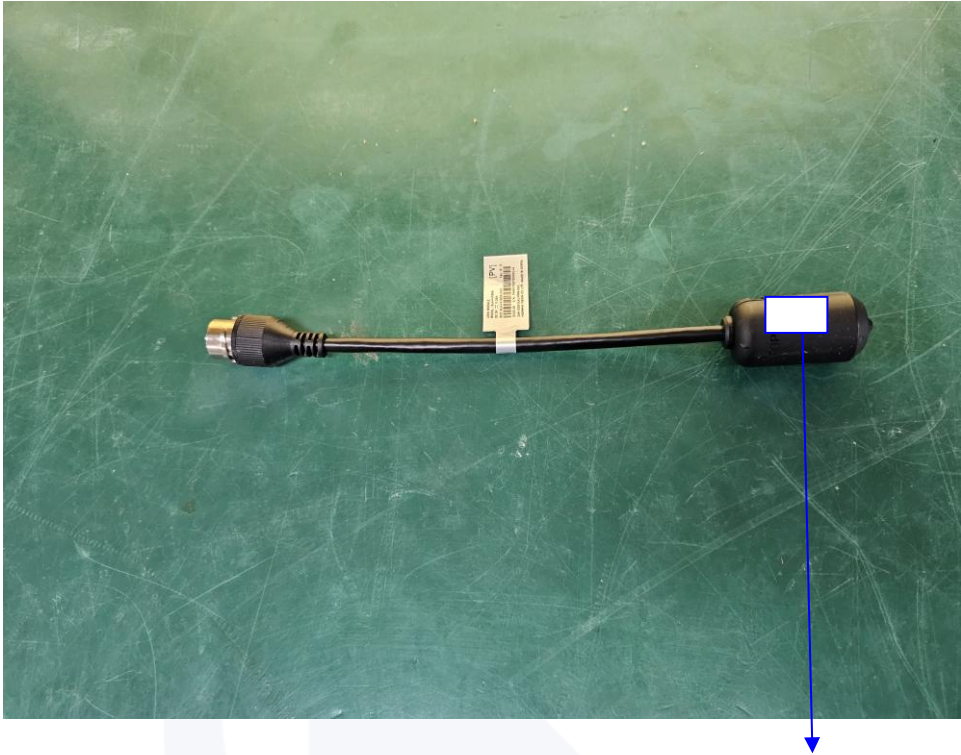


(Bottom)





Label and Location



<u>LENS MODULE</u> Model No : SLA-F4780A Manufacturer : HANWHA VISION VIETNAM COMPANY LIMITED Made in Vietnam	UK CA CE
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The End.